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- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages in Addition to Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

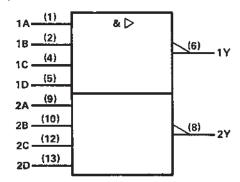
These devices contain two independent 4-input NAND buffer gates.

The SN5440, SN54LS40, and SN54S40 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN7440, SN74LS40, and SN74S40 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

	INP	UTS		OUTPUT
Α	В	С	D	Y
Н	Н	н	н	L
L	X	Х	×	н
Х	L	Х	×	н
Х	Х	L	X	н
х	Х	Х	L	Н

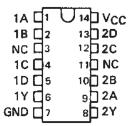
logic symbol†



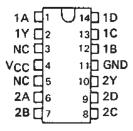
[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

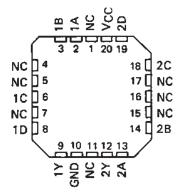
SN5440 . . . J PACKAGE SN54LS40, SN54S40 . . . J OR W PACKAGE SN7440 . . . N PACKAGE SN74LS40, SN74S40 . . . D OR N PACKAGE (TOP VIEW)



SN5440 . . . W PACKAGE (TOP VIEW)

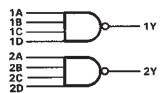


SN54LS40, SN54S40 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram



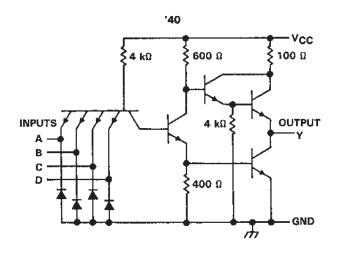
positive logic

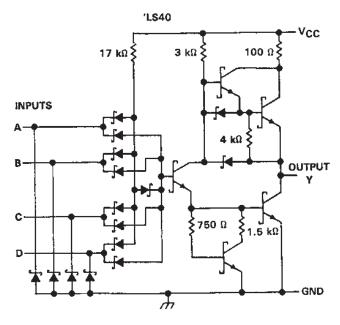
 $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{A + B + C + D}$

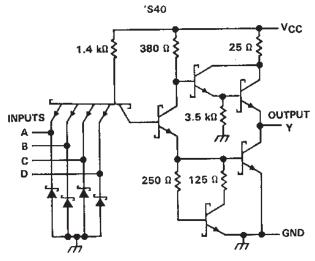


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schematics (each gate)







Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		/
Input voltage: '40, '\$40	5.5 \	/
'LS40		/
Operating free-air temperature range:	SN54')
opoloting noo an temperature resigns	SN74' 0°C to 70°C	2
	65°C to 150°C	

NOTE 1: Voltage values are with respect to network ground terminal.



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recommended operating conditions

			SN5440)		SN7440)	TINU
		MIN	NOM	MAX	MIN	NOM		
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
v_{IH}	High-level input voltage	2			2			٧
VIL	Low-level input voltage			8.0			0.8	V
≓он	High-level output current			1.2			- 1.2	mA
loL	Low-level output current			48			48	mA
TA	Operating free-air temperature	55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDIT	uone t	İ	SN5440)		SN7440)	UNIT
PARAMETER		LEST COMPLI	10145 1	MIN	TYP‡	MAX	MIN	TYP‡	MAX	CHALL
VIK	V _{CC} = MIN,	l ₁ = - 12 mA				1.5			– 1.5	V
Voн	V _{CC} = MIN,	V _{IL} = 0.8 V,	l _{OH} = − 1.2 mA	2.4	3.3		2.4	3.3		V
Vol	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 48 mA		0.2	0.4		0.2	0.4	٧
Ц	V _{CC} = MAX,	V _I = 5.5 V				1_			1	mΑ
ΙΉ	V _{CC} = MAX,	V _I = 2.4 V				40			40	μΑ
I _I L	V _{CC} = MAX,	V _I = 0.4 V				- 1.6			- 1.6	mΑ
IOS §	V _{CC} = MAX			- 20		– 70	- 18		– 70	mΑ
Іссн	V _{CC} = MAX,	V _I = 0			4	8		4	8	mA
ICCL	V _{CC} = MAX,	V _I = 4.5 V			17	27	i	17	27	mA

[†] For conditions shown as MIN or MAX, use the appropriate valua specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

1	BARAMETER	FROM	TO	TEST COM	DITIONS	MIN TYP	MAX	UNIT
-	PARAMETER	(INPUT)	(OUTPUT)	TEST CON	IDITIONS	MIN TYP	WAA	CIVIII
	tPLH	Ami		D. = 122 O	C- = 15 a5	13	22	ns
	tpHŁ.	Αηγ	ľ	R _L = 133 Ω,	CL = 15 pF	8	15	nş

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed 100 milliseconds.

SN5440, SN54LS40, SN54S40 SN7440, SN74LS40, SN74S40 **DUAL 4-INPUT POSITIVE-NAND BUFFERS**

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recommended operating conditions

	SN54	LS40	S	UNIT		
	MIN NO	MAX	MIN	NOM	MAX	Jan
V _{CC} Supply voltage	4.5	5 5.5	4.75	5	5.25	٧
V _{1H} High-level input voltage	2		2	•		
V _{IL} Low-level input voltage		0.7			0.8	V
IOH High-level output current		- 1.2			- 1.2	mΑ
IOL Low-level output current		12			24	mA
TA Operating free-air temperature	- 55	125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TCOT COMPLITIONS \$			N54LS4	Ю	S	N74LS4	Ю	UNIT
PARAMETER	TEST CONDITIONS T			MIN	TYP‡	MAX	MIN	TYP\$	MAX	DIVIT
ViK	V _{CC} = MIN,	I _I = 18 mA	·			1.5			— 1.5	V
VoH	V _{CC} = MIN,	V _{IL} = MAX,	I _{OH} = - 1.2 mA	2.5	3.4		2.7	3.4		٧.
\\ \tag{-}	V _{CC} = M(N,	V _{IH} = 2 V,	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	<
VOL	V _{CC} = MIN,	V _{1H} = 2 V,	I _{OL} = 24 mA					0.35	0.5	L
11	V _{CC} = MAX,	V _J = 7 V				0.1			0.1	mA
чн	V _{CC} = MAX,	V _I = 2.7 V				20			20	μA
115	V _{CC} = MAX,	V _I = 0.4 V				- 0.4			0.4	mA_
IOS §	V _{CC} = MAX			- 30		– 130	- 30		– 130	mA_
^ј ссн	V _{CC} = MAX,	V _I = 0			0.45	1		0.45	1	mA
ICCL	V _{CC} = MAX,	V _I = 4.5 V			3	6		3	6	mΑ

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C (see note 2)

	_								
ſ	PARAMETER	FROM	то	TEST CON	DITIONS	MIN	TYP	MAX	UNIT
١	FANAMETER	(INPUT)	(OUTPUT)	1231 0014					
Γ	tPLH	A	V	D. = 667.0	C. = 45 oF		12	24	ns
r	^t PHL	Апу	1	R _L = 667 Ω,	CL = 45 pF		12	24	ns .

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

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recommended operating conditions

			SN54S4	0		SN74\$4	0	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			8.0			0.8	
loH	High-level output current			- 3		-	- 3	mA
IOL	Low-level output current			60			60	mA
TA	Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

					N54S40			SN74S4)	UNIT
PARAMETER		TEST CONDITIONS T				MAX	MIN	TYP‡	MAX	CIVIT
V _{!K}	V _{CC} = MIN,	I _j = 18 mA				- 1.2			- 1.2	V
Voн	V _{CC} = MIN,	V _{1L} = 0.8 V,	1 _{OH} = - 3 mA	2.5	3.4		2.7	3.4		V
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 60 mA			0.5			0.5	٧
I _I	V _{CC} = MAX,	V _I = 5.5 V				1			1	mΑ
lн	V _{CC} = MAX,	V ₁ = 2.7 V				0.1			0.1	mA
I _{IL}	V _{CC} = MAX,	V _I = 0.5 V				- 4			– 4	mA
los§	V _{CC} = MAX			- 50		- 225	– 50	-	- 225	mA
ICCH	V _{CC} = MAX,	V _I = 0			10	18		10	18	mA
ICCL	V _{CC} = MAX,	V = 4.5 V		i	25	44		25	44	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	DITIONS	MIN TYP	MAX	UNIT
†PLH			R _L = 93 Ω,	C ₁ = 50 pF	4	6.5	กร
t _{PHL}	Апу		n 93 ss,		4	6.5	ns
^t PLH	Ally	' [RL = 93 Ω,	C _L = 150 pF	6		nş
†PHL			NL - 30 11,	о <u>г</u> 130 р.	6		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

^{Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed 100 milliseconds.}

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